	Application No.	Applicant(s)
Notice of Allowability	10/017 073	SINDUI SHAVANA ET AL
	10/017,073 Examiner	SINDHUSHAYANA ET AL. Art Unit
	Jacon M. Barilla	2020
	Jason M. Perilla	2638
The MAILING DATE of this communication appears all claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in this ap or other appropriate communication IGHTS. This application is subject t	oplication. If not included n will be mailed in due course. THIS
1. 🔀 This communication is responsive to the amendment filed	October 5, 2005.	
2. X The allowed claim(s) is/are 1-3, 8, 13, and 25-34 renumbe	red as claims 1-15.	
 Acknowledgment is made of a claim for foreign priority ur a) ☐ All b) ☐ Some* c) ☐ None of the: 	nder 35 U.S.C. § 119(a)-(d) or (f).	
 Certified copies of the priority documents have 	e been received.	
Certified copies of the priority documents have	e been received in Application No	-
5. ☐ Copies of the certified copies of the priority documents have been received in this national stage application from the		
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		complying with the requirements
4. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give		
5. CORRECTED DRAWINGS (as "replacement sheets") mus	st be submitted.	
(a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached		
1) ☐ hereto or 2) ☐ to Paper No./Mail Date		
(b) including changes required by the attached Examiner' Paper No./Mail Date	s Amendment / Comment or in the 0	Office action of
Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t		
 DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT 	sit of BIOLOGICAL MATERIAL FOR THE DEPOSIT OF BIOLOGIC	must be submitted. Note the CAL MATERIAL.
Attachment(s) 1. ☐ Notice of References Cited (PTO-892)	5 🗆 Notice of Informal E	Patent Application (PTO-152)
Notice of Neterences Cited (110-092) Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ☑ Interview Summary	· · · · · · · · · · · · · · · · · · ·
_ , ,	Paper No./Mail Da	ite <u>20051024</u> .
 Information Disclosure Statements (PTO-1449 or PTO/SB/C Paper No./Mail Date 	08), 7. ⊠ Examiner's Amend	menvComment
Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. ⊠ Examiner's Statem 9. □ Other	ent of Reasons for Allowance
KENNETH VANDERPUYE SUPERVISORY PATENT EXAMINER		

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EXAMINER'S AMENDMENT

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1. Claims 1-3, 8, 9, 13, and 25-34 are pending in the instant application.

2. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

Authorization for this examiner's amendment was given in a telephone interview with George Pappas on October 21, 2005.

The application has been amended as follows wherein the following versions of claims 1, 25-28, and 31-34 replace all prior versions in their entirety and claim 9 is cancelled:

- 1. A searcher for finding the frequency of a received signal comprising a phase error, the searcher comprising:
- a frequency locked loop that generates a phase increment signal in response to the phase error of the received signal;
- a programmable rotator coupled to the frequency locked loop, the programmable rotator performing a phase rotation function;
- a phase error accumulator accumulating results of the phase increment signals from the frequency locked loop and generating a control signal that instructs the programmable rotator to perform the phase rotation function; and
- a shift register coupled between the phase error accumulator and the programmable rotator, the shift register truncating a predetermined number of bits of the control signal.

wherein the frequency locked loop further comprises means for generating an initial phase signal that is coupled to the programmable rotator and initializes the programmable rotator to a predetermined starting phase.

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- 9. (CANCELLED) The searcher of claim-2 wherein the frequency locked loop further comprises means for generating an initial phase signal that is coupled to the 8-Phase Shift Keying programmable rotator and initializes the 8-Phase Shift Keying programmable rotator to a predetermined starting phase.
- 25. A searcher for finding the frequency of a received signal comprising a plurality of segments, the searcher comprising:

a first phase rotator configured to phase rotate a signal to partially reduce a phase error of the signal and produce a first phase rotator output signal;

an accumulator configured to accumulate a plurality of chips from the first phase rotator output signal to form segments of the first phase rotator output signal;

a second rotator configured to phase rotate the segments of the first phase rotator output signal to further reduce the <u>a</u> phase error of the signal segments by adjusting the phase over each segment; and

wherein the second rotator is implemented within a frequency locked loop producing a phase increment signal based on the phase error of the segments, the first phase rotator configured to phase rotate the signal based on an accumulation of the phase increment signal.

- 26. A searcher in accordance with claim 25, wherein the second rotator is implemented within a frequency locked loop producing a phase increment signal based on the phase error of the segments, the first phase rotator configured to phase rotate the signal based on the phase increment signal.
- 27. A searcher in accordance with claim 26, wherein the first phase rotator is configured to partially reduce the phase error of the signal by compensating for instantaneous signal phase changes over each segment.
- 28. A searcher in accordance with claim 27, wherein the second phase rotator is configured to partially phase rotate the signal segments based on an average phase of the signal over multiple segments chips.
- 31. A method of finding a signal having a deviation from an expected frequency, the method comprising:

first phase rotating a signal to partially reduce a phase error of the signal and produce a partially rotated output signal;

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accumulating a plurality of chips from the partially rotated output signal to form segments of the partially rotated output signal;

second phase rotating the segments of the partially rotated output signal to further reduce the <u>a</u> phase error of the signal segments by adjusting the phase over each segment; and

generating a phase increment signal based on the phase error of the segments, the first phase rotating the signal to partially reduce the phase error of the signal based on an accumulation of the phase increment signal.

- 32. A method in accordance with claim 31, further comprising:

 generating a phase increment signal based on the phase error of the

 segments, the first phase rotating the signal to partially reduce the phase error of the

 signal based on the phase increment signal.
- 33. A method in accordance with claim 32, wherein the <u>first</u> phase rotating the signal to partially reduce the phase error <u>of the signal</u> comprises compensating for instantaneous signal phase changes over each segment.
- 34. A method in accordance with claim 33, wherein the <u>second</u> phase rotating the signal to further reduce the phase error <u>of the segments</u> comprises compensating for instantaneous signal phase changes over each segment by partially phase rotating the signal based on an average phase of the signal over multiple segments chips.

Claims 31-34 are renumbered as claims 1-4, claims 25-30 are renumbered as claims 5-10, claims 1-3, 8, and 13 are renumbered as claims 11-15, and the claim dependency is renumbered accordingly.

Allowable Subject Matter

- Claims 1-3, 8, 13, and 25-34 renumbered as claims 1-15 are allowed.
- 4. The following is an examiner's statement of reasons for allowance:

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Claims 1-3, 8, 13, and 25-34 renumbered as claims 1-15 are allowed because the prior art of record does not disclose or obviate any of the independent claims 1, 25, or 31. That is, the prior art of record does not disclose a frequency locked loop as claimed in claim 1 having a means for generating an initial phase signal and a shift register coupled between the phase error accumulator and the programmable rotator. Regarding independent claims 25 and 34, the prior art of record does not disclose or obviate a frequency locked loop having accumulators preceding both a first and a second phase rotator as claimed.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jason M. Perilla whose telephone number is (571) 272-3055. The examiner can normally be reached on M-F 8-5 EST.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Kenneth Vanderpuye can be reached on (571) 272-3078. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

KENNETH VANDERPUYE
SUPERVISORY PATENT EXAMINER

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Jason M. Perilla October 24, 2005

jmp